Notice of References Cited

Application/Control No. 10/765,969	Reexamination	Applicant(s)/Patent Under Reexamination TAKABAYASHI ET AL.	
Examiner	Art Unit		
Robert J. Sandv	3677	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,559,055	12-1985	Ogunro, E. Olayinka	132/73
	В	US-4,445,234	05-1984	Ogunro, E. Olayinka	623/54
	С	US-6,488,506	12-2002	Grace et al.	132/73
	D	US-5,413,123	05-1995	Aylott et al.	132/73
	Е	US-6,488,506	12-2002	Grace et al.	132/73
	F	US-6,260,244	07-2001	Noda, Taizoh	24/499
	G	US-5,778,497	07-1998	Noda, Taizo	24/504
	н	US-5,400,483	03-1995	Noda, Taizo	24/499
	ı	US-4,086,686	05-1978	Takabayashi, Teruo	24/504
	J	US-3,914,828	10-1975	Noda, Taizo	24/504
	к	US-277,700	05-1883	C.W. Foster	24/504
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
	w			
	×			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.